Se	arcn Notes	
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/796,146	NIHEI ET AL.	
Examiner	Art Unit	
Thanhha Pham	2813	

SEARCHED				
Class	Subclass	Date	Examiner	
257	276	12/4/2006	TSP	
	625			
	77			
UPDATED	SEARCH	6/5/2007	TSP	
257	718, 720	6/8/2007	TSP	
	e51.04			
	e23.074			
	e23.11			
UPDATED	SEARCH	12/8/2007	TSP	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examinėr
		97	
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	ARCH NOTES SEARCH STR	ATEGY)	
		DATE	
EAST	12	/4/2006	TSP
EAST	1	2/9/06	TSP
EAST	6/	5/2007	TSP ·
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